TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (-MOSVII)

TPCA8006-H

Switching Regulator Applications Motor Drive Applications

- Small footprint due to small and thin package
- High speed switching
- Low drain-source ON resistance

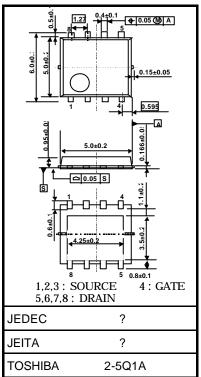
: RDS (ON) = 41 mO (typ.) (VG=10V, ID=9A)

- High forward transfer admittance: $|Y_{fs}| = 15 S$ (typ.)
- Low leakage current: IDSS = $100 \,\mu\text{A}$ (max) (VDS = $100 \,\text{V}$)
- Enhancement mode: $V_{th} = 3.0 \text{ to } 5.0 \text{ V } (V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

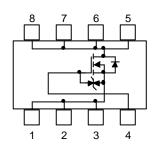
Characte	ristics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	100	V	
Drain-gate voltage (F	$R_{GS} = 20 \text{ k}\Omega$	V_{DGR}	100	V	
Gate-source voltage		V_{GSS}	±20	V	
Drain current	DC (Note 1)	l _D	18	А	
Diam current	Pulsed (Note 1)	l _{DP}	36	Α	
Drain power dissipation	on (Tc=25)	P_{D}	45	W	
Drain power dissipation	on $(t = 10 s)$ (Note 2a)	P_{D}	2.8	W	
Drain power dissipation	on $(t = 10 s)$ (Note 2b)	P_{D}	1.6	W	
Single pulse avalanch	ne energy (Note 3)	E _{AS}	224	mJ	
Avalanche current		I _{AR}	18	Α	
Repetitive avalanche energy (Note 2a) (Note 4)		E _{AR}	4.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature	range	T _{stg}	-55 to 150	°C	

Unit: mm



Weight: 0.080 g (typ.)

Circuit Configuration



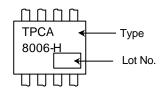
Note: For (Note 1), (Note 2), (Note 3), (Note 4), please refer to the next page.

This transistor is an electrostatic sensitive device. Please handle with caution.

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case (Tc=25)	R _{th (ch-c)}	2.78	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R _{th (ch-a)}	44.6	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R _{th (ch-a)}	78.1	°C/W

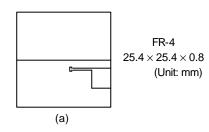
Marking (Note 5)

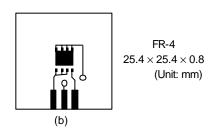


Note 1: Please use devices on condition that the channel temperature is below 150 °C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)

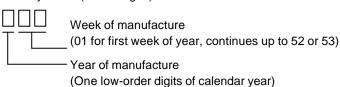




Note 3: $V_{DD} = 50~V$, $T_{ch} = 25^{\circ}C$ (initial) , L = 0.8~mH , $R_G = 25~\Omega$, $I_{AR} = 18~A$

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: * Weekly code: (Three digits)



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Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		l _{GSS}	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	nA
Drain cut-OFF cu	urrent	l _{DSS}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$	_	_	100	μΑ
Drain-source bre	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	100	_	_	V
Gate threshold v	oltage	V_{th}	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	3.0	_	5.0	V
Drain-source ON resistance		R _{DS (ON)}	$V_{GS} = 10 \text{ V}, I_D = 9 \text{ A}$	_	41	67	mΩ
Forward transfer admittance		Y _{fs}	$V_{DS} = 10 \text{ V}, I_{D} = 9 \text{ A}$	7.5	15	_	S
Input capacitance		C _{iss}		_	780	_	pF
Reverse transfer capacitance		C _{rss}	$V_{DS} = 10 V, V_{GS} = 0 V, f = 1 MHz$	_	17	_	
Output capacitance		C _{oss}		_	390	_	
Switching time	Rise time	t _r	VGS 10 V	_	(3)		ns
	Turn-ON time	t _{on}		_	(13)	_	
	Fall time	t _f		_	2	_	
	Turn-OFF time	t _{off}	$V_{DD} \simeq 50 \text{ V}$ Duty $\leq 1\%$, $t_w = 10 \mu\text{s}$	_	13	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \approx 80 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}$		12		nC
Gate-source charge 1		Q _{gs1}			5.6		
Gate-drain ("miller") charge		Q_{gd}			4.0	_	
Gate switch charge		Q _{SW}]	_	6.9	_	

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteris	stics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse	I _{DRP}	_	_	_	36	Α
Forward voltage (diode)		V_{DSF}	$I_{DR} = 18 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.7	V

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